

# MOSFET

Metal Oxide Semiconductor Field Effect Transistor

## CoolMOS™ C6 650V

650V CoolMOS™ C6 Power Transistor  
IPD65R950C6

## Data Sheet

Rev. 2.0  
Final

Industrial & Multimarket

## 1 Description

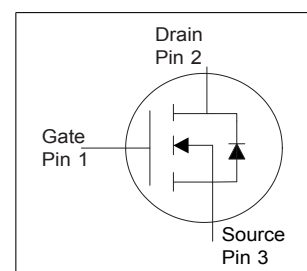
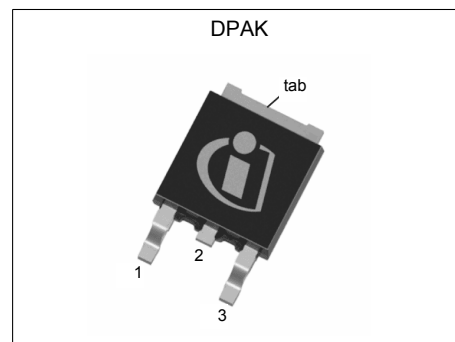
CoolMOS™ is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies. CoolMOS™ C6 series combines the experience of the leading SJ MOSFET supplier with high class innovation. The resulting devices provide all benefits of a fast switching SJ MOSFET while not sacrificing ease of use. Extremely low switching and conduction losses make switching applications even more efficient, more compact, lighter and cooler.

## Features

- Extremely low losses due to very low FOM  $R_{ds(on)} \cdot Q_g$  and  $E_{oss}$
- Very high commutation ruggedness
- Easy to use/drive
- Pb-free plating, Halogen free mold compound
- Qualified for industrial grade applications according to JEDEC (J-STD20 and JESD22)

## Applications

Hard switching PWM stages and resonant switching PWM stages for e.g. PC Silverbox, Adapter, LCD & PDP TV and Lighting.



**Table 1 Key Performance Parameters**

| Parameter            | Value | Unit       |
|----------------------|-------|------------|
| $V_{DS} @ T_{j,max}$ | 700   | V          |
| $R_{DS(on),max}$     | 0.95  | $\Omega$   |
| $Q_g,typ$            | 15.3  | nC         |
| $I_D,pulse$          | 12    | A          |
| $E_{oss} @ 400V$     | 1.5   | $\mu J$    |
| Body diode $di/dt$   | 500   | A/ $\mu s$ |

| Type / Ordering Code | Package   | Marking | Related Links  |
|----------------------|-----------|---------|----------------|
| IPD65R950C6          | PG-TO 252 | 65C6950 | see Appendix A |

## Table of Contents

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## 2 Maximum ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 2 Maximum ratings**

| Parameter                              | Symbol         | Values |      |      | Unit             | Note / Test Condition                                                                             |
|----------------------------------------|----------------|--------|------|------|------------------|---------------------------------------------------------------------------------------------------|
|                                        |                | Min.   | Typ. | Max. |                  |                                                                                                   |
| Continuous drain current <sup>1)</sup> | $I_D$          |        |      | 4.5  | A                | $T_C = 25^\circ\text{C}$                                                                          |
|                                        |                |        |      | 2.8  |                  | $T_C = 100^\circ\text{C}$                                                                         |
| Pulsed drain current <sup>2)</sup>     | $I_{D,pulse}$  |        |      | 12   | A                | $T_C = 25^\circ\text{C}$                                                                          |
| Avalanche energy, single pulse         | $E_{AS}$       |        |      | 50   | mJ               | $I_D = 1.0\text{A}$ , $V_{DD} = 50\text{V}$<br>(see table 10)                                     |
| Avalanche energy, repetitive           | $E_{AR}$       |        |      | 0.15 | mJ               | $I_D = 1.0\text{A}$ , $V_{DD} = 50\text{V}$                                                       |
| Avalanche current, repetitive          | $I_{AR}$       |        |      | 1.0  | A                |                                                                                                   |
| MOSFET dv/dt ruggedness                | dv/dt          |        |      | 50   | V/ns             | $V_{DS} = 0 \dots 480\text{V}$                                                                    |
| Gate source voltage                    | $V_{GS}$       | -20    |      | 20   | V                | static                                                                                            |
|                                        |                | -30    |      | 30   |                  | AC ( $f > 1\text{ Hz}$ )                                                                          |
| Operating and storage temperature      | $T_j, T_{stg}$ | -55    |      | 150  | $^\circ\text{C}$ |                                                                                                   |
| Continuous diode forward current       | $I_S$          |        |      | 3.9  | A                | $T_C = 25^\circ\text{C}$                                                                          |
| Diode pulse current                    | $I_{S,pulse}$  |        |      | 12   | A                | $T_C = 25^\circ\text{C}$                                                                          |
| Reverse diode dv/dt <sup>3)</sup>      | dv/dt          |        |      | 15   | V/ns             | $V_{DS} = 0 \dots 400\text{V}$ , $I_{SD} \leq I_D$ ,<br>$T_j = 25^\circ\text{C}$<br>(see table 8) |
| Maximum diode commutation speed        | di/dt          |        |      | 500  | A/ $\mu\text{s}$ |                                                                                                   |
| Power dissipation                      | $P_{tot}$      |        |      | 37   | W                | $T_C = 25^\circ$                                                                                  |

<sup>1)</sup> Limited by  $T_{j,max}$ . Maximum duty cycle  $D=0.75$

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{j,max}$

<sup>3)</sup> Identical low side and high side switch with identical  $R_G$

### 3 Thermal characteristics

**Table 3 Thermal characteristics DPAK**

| Parameter                                              | Symbol     | Values |      |      | Unit | Note / Test Condition                                     |
|--------------------------------------------------------|------------|--------|------|------|------|-----------------------------------------------------------|
|                                                        |            | Min.   | Typ. | Max. |      |                                                           |
| Thermal resistance, junction - case                    | $R_{thJC}$ |        |      | 3.4  | °C/W |                                                           |
| Thermal resistance, junction - ambient <sup>1)</sup>   | $R_{thJA}$ |        |      | 62   | °C/W | leaded                                                    |
|                                                        |            |        | 35   |      |      | SMD version, device on PCB, 6cm <sup>2</sup> cooling area |
| Soldering temperature, wave- & reflowsoldering allowed | $T_{sold}$ |        |      | 260  | °C   | 1.6 mm (0.063 in.) from case for 10s                      |

<sup>1)</sup> Device on 40mm\*40mm\*1.5mm one layer epoxy PCB FR4 with 6cm<sup>2</sup> copper area (thickness 70µm) for drain connection.  
PCB is vertical without air stream cooling.

## 4 Electrical characteristics

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 4 Static characteristics**

| Parameter                        | Symbol        | Values |       |      | Unit     | Note / Test Condition                           |
|----------------------------------|---------------|--------|-------|------|----------|-------------------------------------------------|
|                                  |               | Min.   | Typ.  | Max. |          |                                                 |
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | 650    |       |      | V        | $V_{GS} = 0V, I_D = 1mA$                        |
| Gate threshold voltage           | $V_{GS(th)}$  | 2.5    | 3     | 3.5  | V        | $V_{DS} = V_{GS}, I_D = 0.2mA$                  |
| Zero gate voltage drain current  | $I_{DSS}$     |        |       | 1    | $\mu A$  | $V_{DS} = 650V, V_{GS} = 0V, T_j = 25^\circ C$  |
|                                  |               |        | 10    |      |          | $V_{DS} = 650V, V_{GS} = 0V, T_j = 150^\circ C$ |
| Gate-source leakage current      | $I_{GSS}$     |        |       | 100  | nA       | $V_{GS} = 20V, V_{DS} = 0V$                     |
| Drain-source on-state resistance | $R_{DS(on)}$  |        | 0.855 | 0.95 | $\Omega$ | $V_{GS} = 10V, I_D = 1.5A, T_j = 25^\circ C$    |
|                                  |               |        | 2.223 |      |          | $V_{GS} = 10V, I_D = 1.5A, T_j = 150^\circ C$   |
| Gate resistance                  | $R_G$         |        | 5.5   |      | $\Omega$ | $f = 1MHz$ , open drain                         |

**Table 5 Dynamic characteristics**

| Parameter                                                  | Symbol       | Values |      |      | Unit | Note / Test Condition                                                        |
|------------------------------------------------------------|--------------|--------|------|------|------|------------------------------------------------------------------------------|
|                                                            |              | Min.   | Typ. | Max. |      |                                                                              |
| Input capacitance                                          | $C_{iss}$    |        | 328  |      | pF   | $V_{GS} = 0V, V_{DS} = 100V, f = 1MHz$                                       |
| Output capacitance                                         | $C_{oss}$    |        | 23   |      | pF   |                                                                              |
| Effective output capacitance, energy related <sup>1)</sup> | $C_{o(er)}$  |        | 14   |      | pF   | $V_{GS} = 0V, V_{DS} = 0 \dots 480V$                                         |
| Effective output capacitance, time related <sup>2)</sup>   | $C_{o(tr)}$  |        | 58.5 |      | pF   | $I_D = \text{constant}, V_{GS} = 0V, V_{DS} = 0 \dots 480V$                  |
| Turn-on delay time                                         | $t_{d(on)}$  |        | 6.6  |      | ns   | $V_{DD} = 400V, V_{GS} = 13V, I_D = 2.2A, R_G = 10.2\Omega$<br>(see table 9) |
| Rise time                                                  | $t_r$        |        | 5.2  |      | ns   |                                                                              |
| Turn-off delay time                                        | $t_{d(off)}$ |        | 41   |      | ns   |                                                                              |
| Fall time                                                  | $t_f$        |        | 13.6 |      | ns   |                                                                              |

**Table 6 Gate charge characteristics**

| Parameter             | Symbol        | Values |      |      | Unit | Note / Test Condition                                   |
|-----------------------|---------------|--------|------|------|------|---------------------------------------------------------|
|                       |               | Min.   | Typ. | Max. |      |                                                         |
| Gate to source charge | $Q_{gs}$      |        | 1.8  |      | nC   | $V_{DD} = 480V, I_D = 2.2A, V_{GS} = 0 \text{ to } 10V$ |
| Gate to drain charge  | $Q_{gd}$      |        | 8    |      | nC   |                                                         |
| Gate charge total     | $Q_g$         |        | 15.3 |      | nC   |                                                         |
| Gate plateau voltage  | $V_{plateau}$ |        | 5.1  |      | V    |                                                         |

<sup>1)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{(BR)DSS}$

<sup>2)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{(BR)DSS}$

**Table 7 Reverse diode characteristics**

| Parameter                     | Symbol    | Values |      |      | Unit    | Note / Test Condition                                                |
|-------------------------------|-----------|--------|------|------|---------|----------------------------------------------------------------------|
|                               |           | Min.   | Typ. | Max. |         |                                                                      |
| Diode forward voltage         | $V_{SD}$  |        | 0.9  |      | V       | $V_{GS} = 0V, I_F = 2.2A, T_j = 25^\circ C$                          |
| Reverse recovery time         | $t_{rr}$  |        | 226  |      | ns      | $V_R = 400V, I_F = 2.2A,$<br>$di_F/dt = 100A/\mu s$<br>(see table 8) |
| Reverse recovery charge       | $Q_{rr}$  |        | 1.3  |      | $\mu C$ |                                                                      |
| Peak reverse recovery current | $I_{rrm}$ |        | 9.9  |      | A       |                                                                      |

## 5 Electrical characteristics diagrams

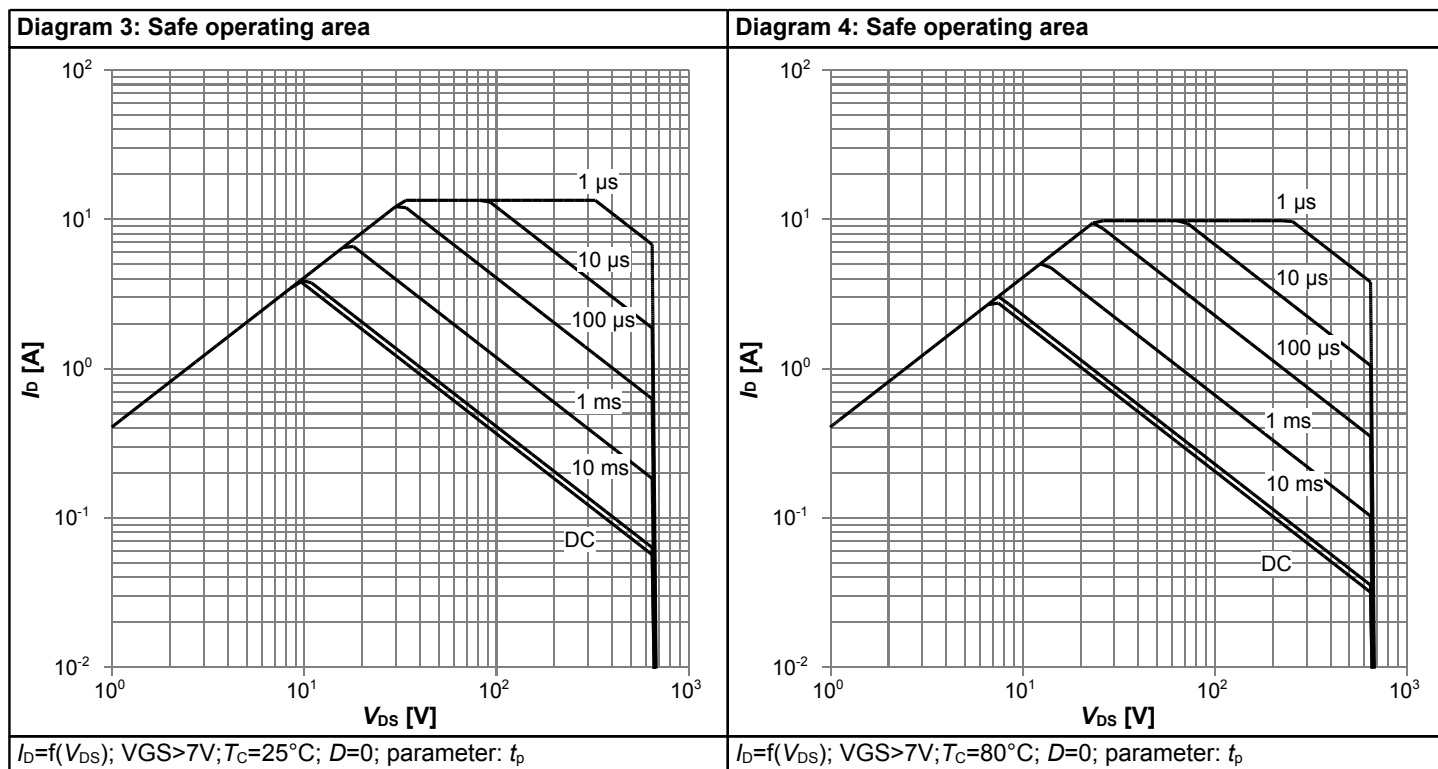
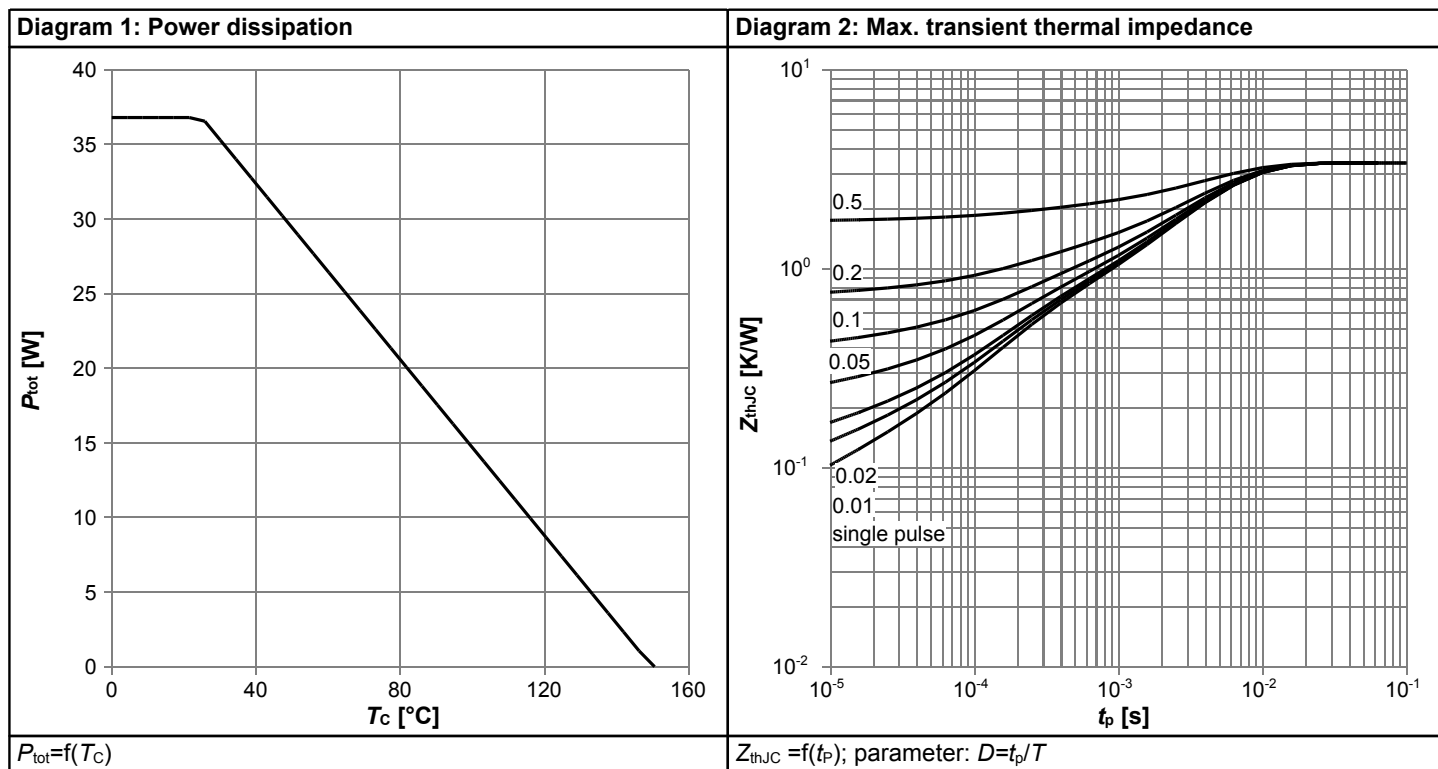




Diagram 5: Typ. output characteristics

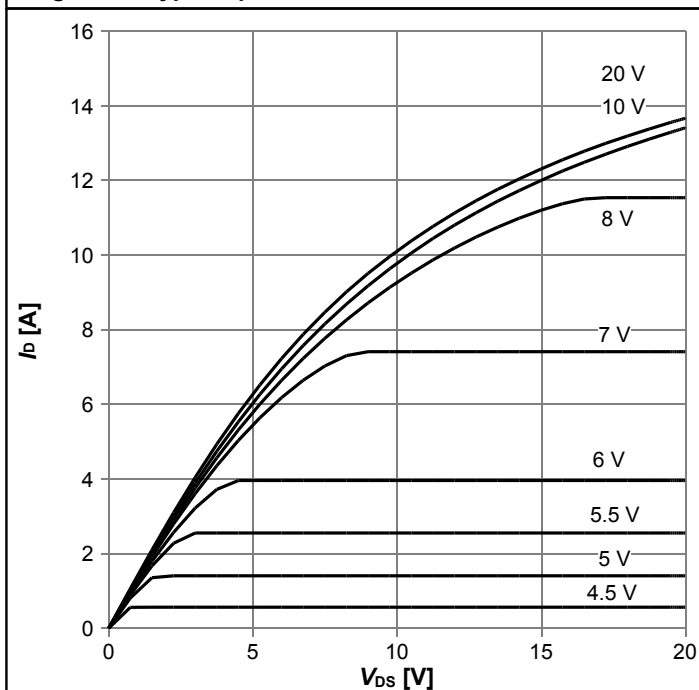

 $I_D = f(V_{DS}); T_J = 25^\circ\text{C}; \text{parameter: } V_{GS}$ 

Diagram 6: Typ. output characteristics

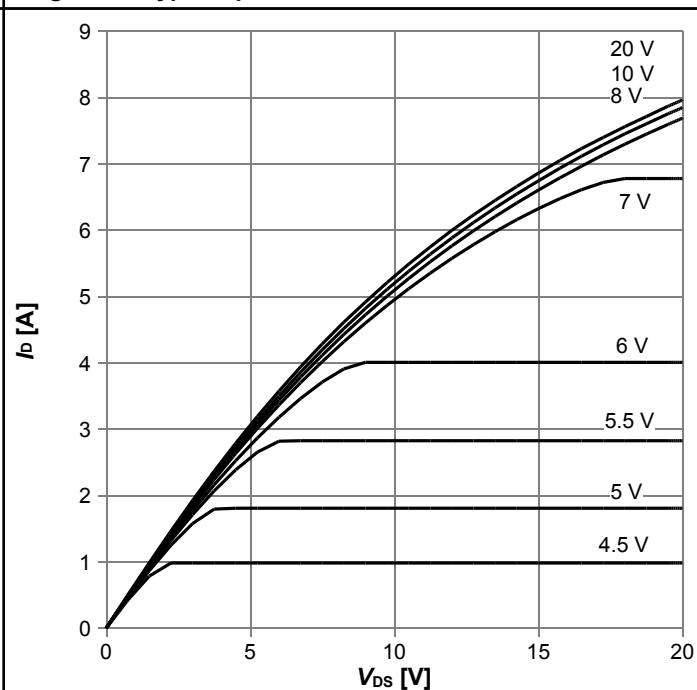

 $I_D = f(V_{DS}); T_J = 125^\circ\text{C}; \text{parameter: } V_{GS}$ 

Diagram 7: Typ. drain-source on-state resistance

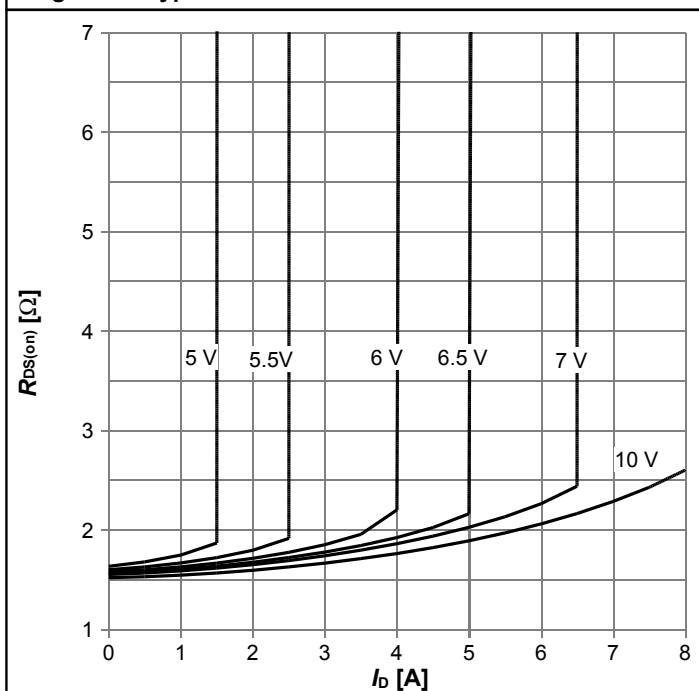

 $R_{DS(on)} = f(I_D); T_J = 125^\circ\text{C}; \text{parameter: } V_{GS}$ 

Diagram 8: Drain-source on-state resistance

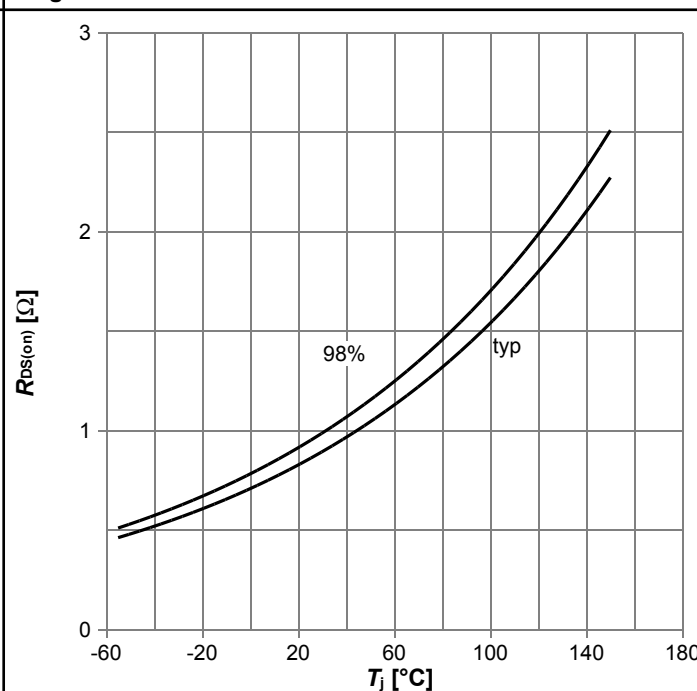

 $R_{DS(on)} = f(T_J); I_D = 1.5\text{ A}; V_{GS} = 10\text{ V}$

Diagram 9: Typ. transfer characteristics

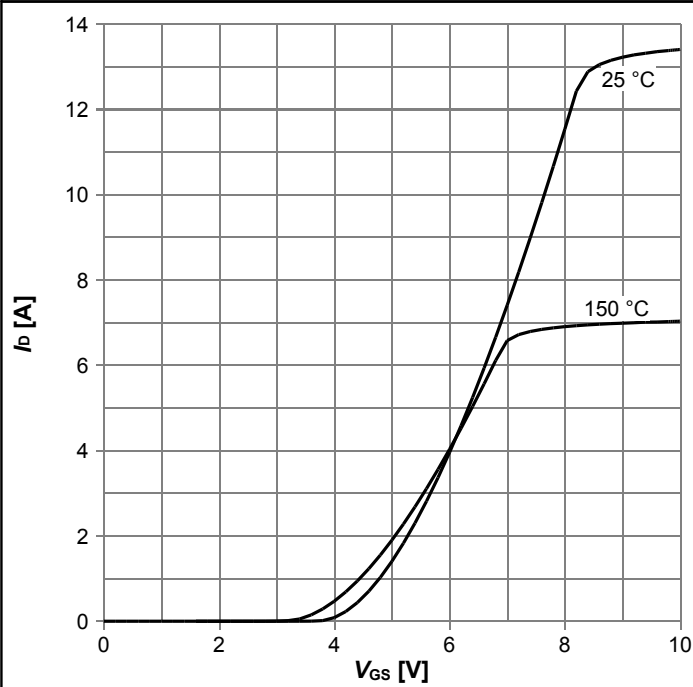

 $I_D = f(V_{GS}); V_{DS} = 20V; \text{parameter: } T_j$ 

Diagram 10: Typ. gate charge

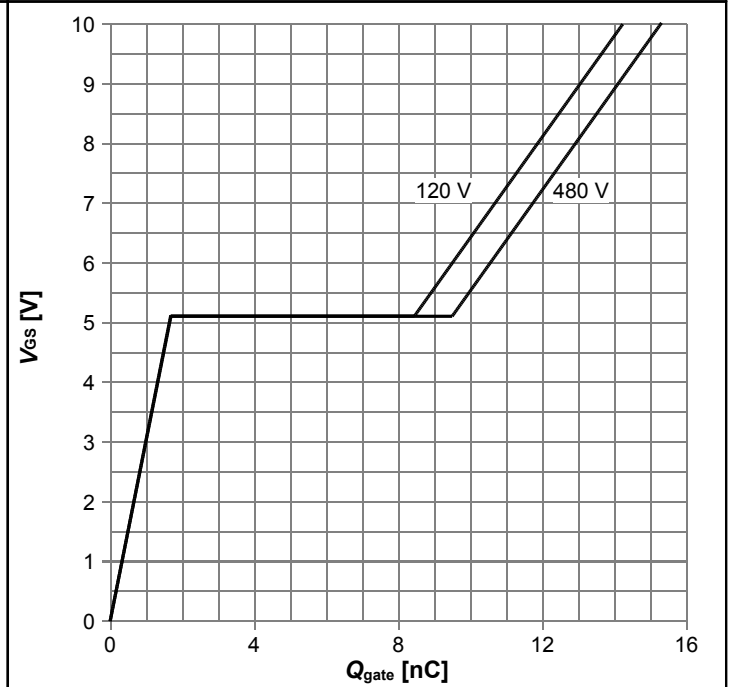

 $V_{GS} = f(Q_{gate}); I_D = 1.5 \text{ A pulsed}; \text{parameter: } V_{DD}$ 

Diagram 11: Avalanche energy

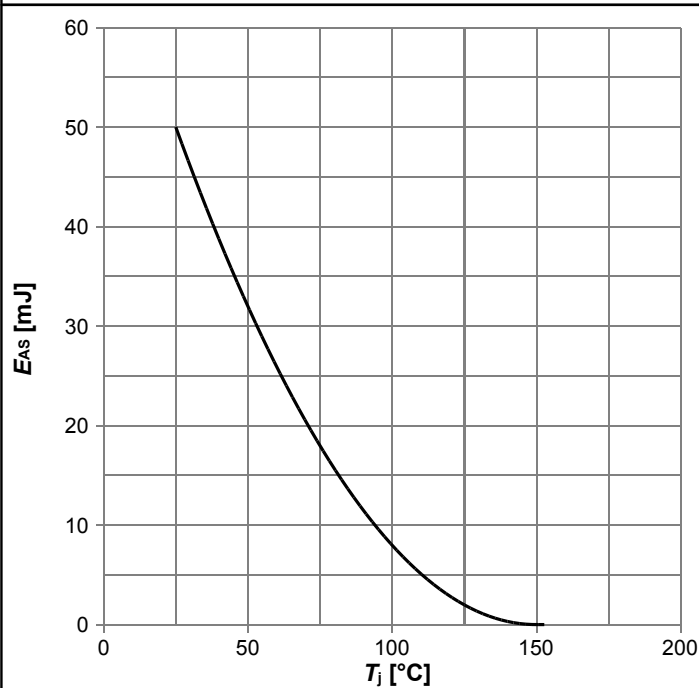

 $E_{AS} = f(T_j); I_D = 1.0 \text{ A}; V_{DD} = 50 \text{ V}$ 

Diagram 12: Drain-source breakdown voltage

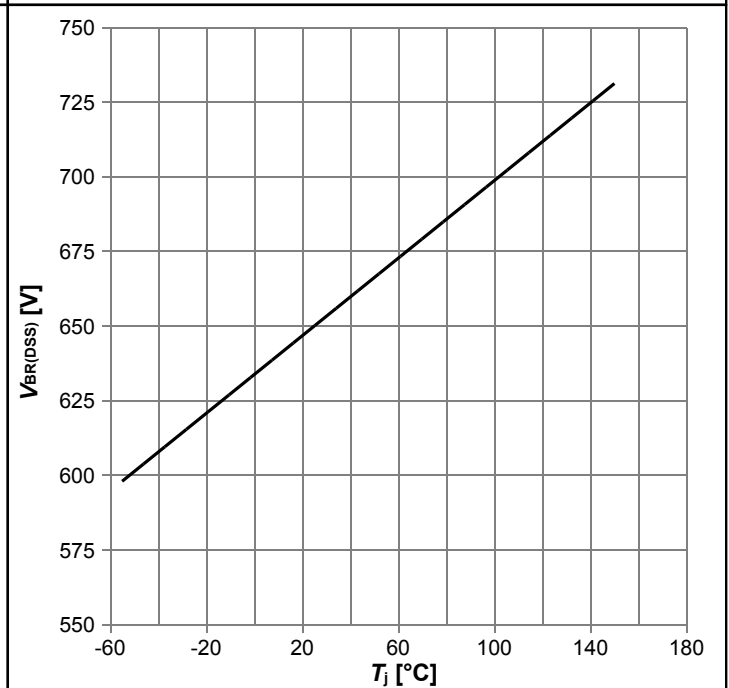
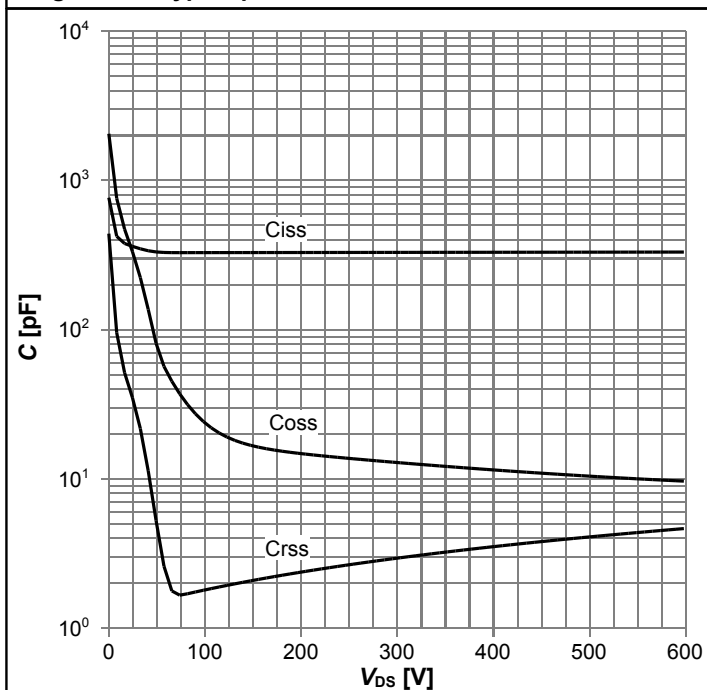
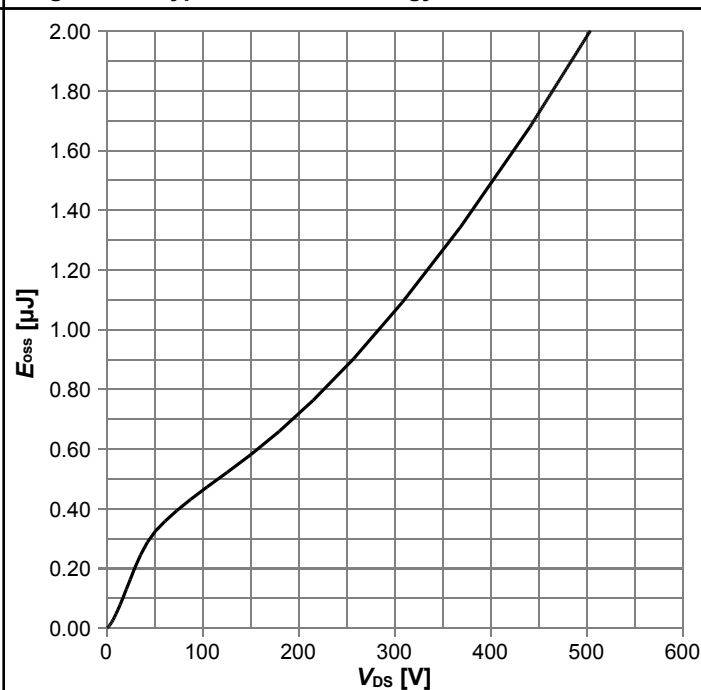

 $V_{BR(DSS)} = f(T_j); I_D = 1.0 \text{ mA}$

Diagram 13: Typ. capacitances



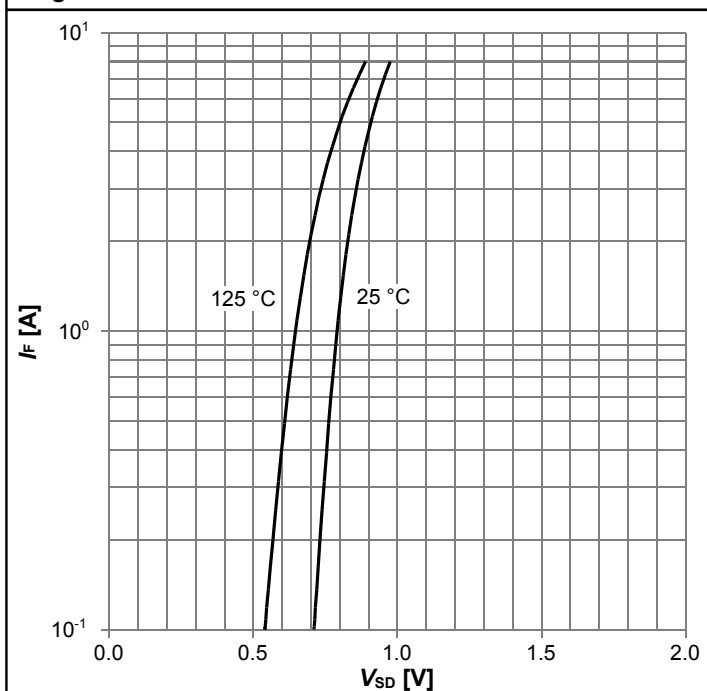
$$C=f(V_{DS}); V_{GS}=0\text{ V}; f=1\text{ MHz}$$

Diagram 14: Typ. Coss stored energy



$$E_{oss}=f(V_{DS})$$

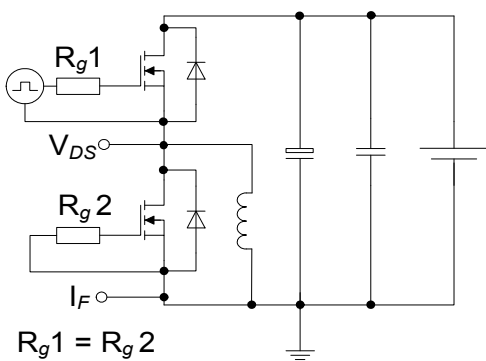
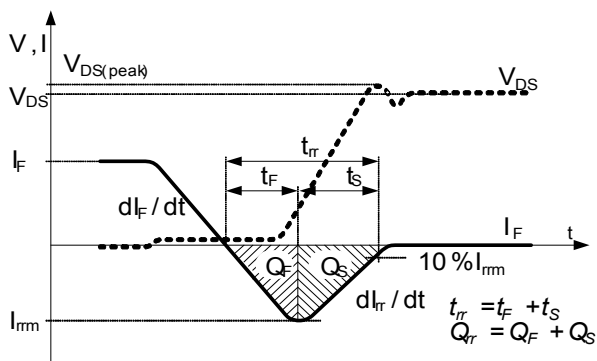
Diagram 15: Forward characteristics of reverse diode



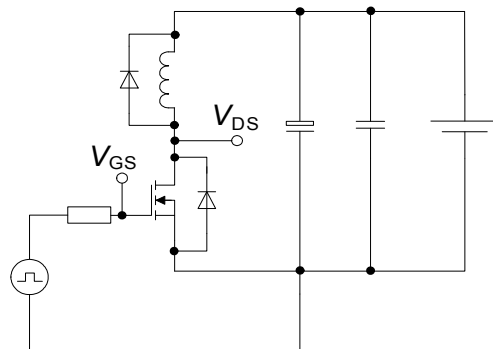
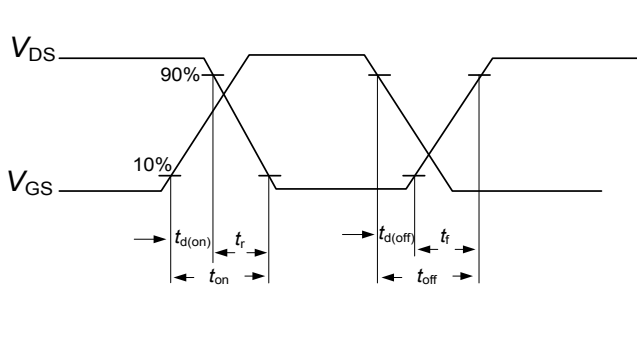
$$I_F=f(V_{SD}); \text{ parameter: } T_j$$

## 6 Test Circuits

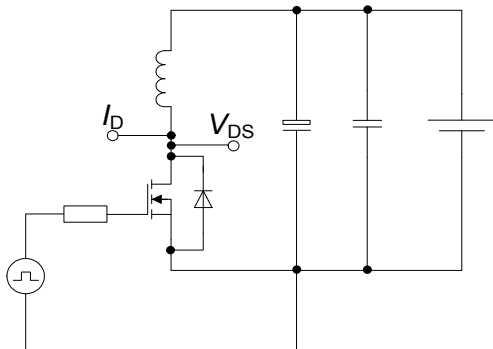
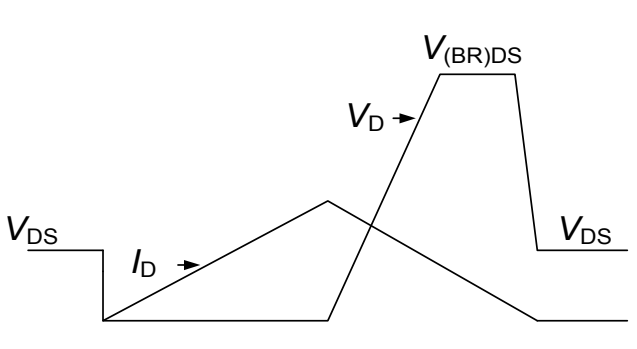
**Table 8 Diode characteristics**

| Test circuit for diode characteristics                                                                                | Diode recovery waveform                                                                                                                                        |
|-----------------------------------------------------------------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------|
|  <p><math>R_{g1} = R_{g2}</math></p> |  <p><math>t_{rr} = t_F + t_S</math><br/> <math>Q_{rr} = Q_F + Q_S</math></p> |

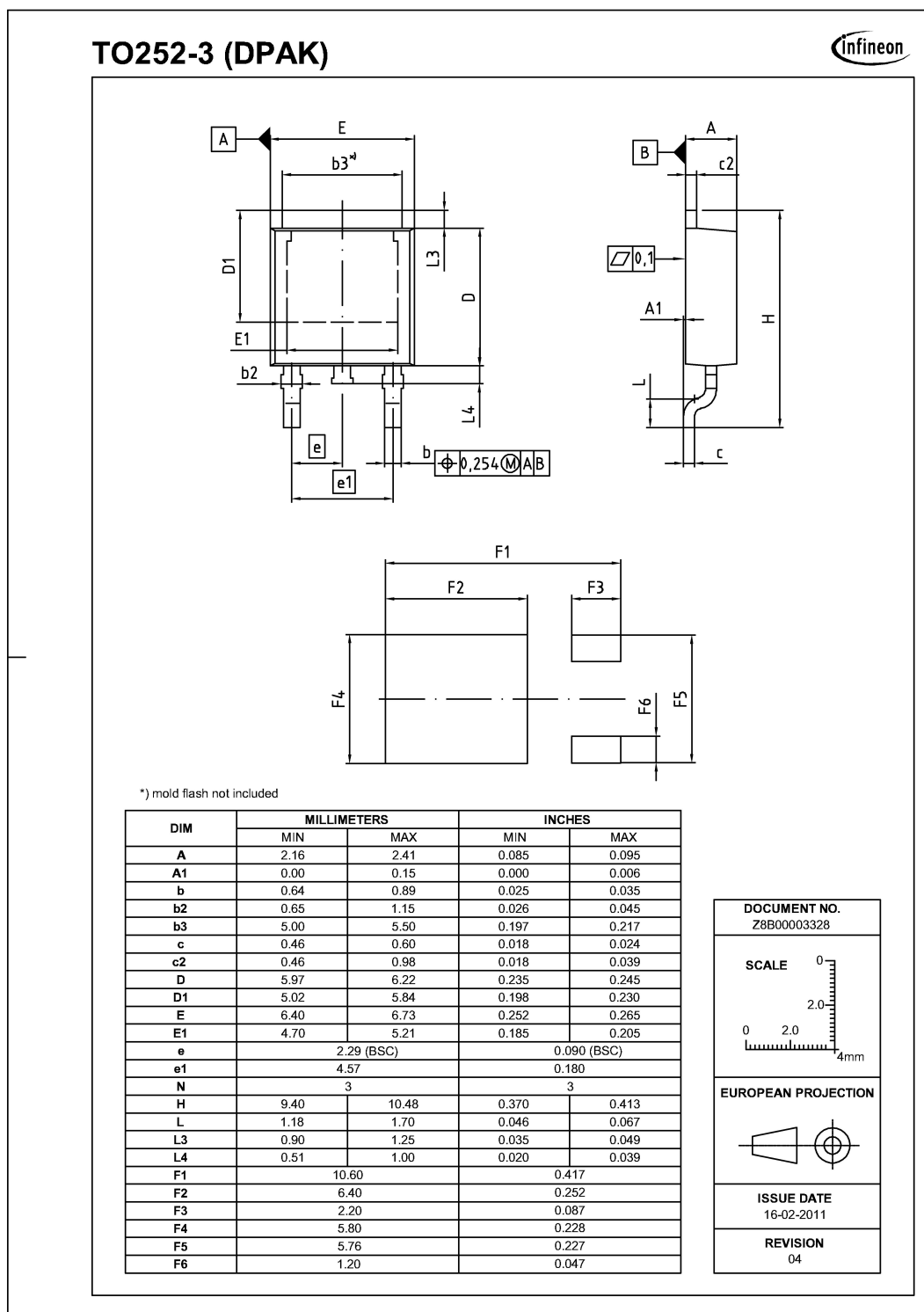
**Table 9 Switching times**

| Switching times test circuit for inductive load                                     | Switching times waveform                                                             |
|-------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------|
|  |  |

**Table 10 Unclamped inductive load**

| Unclamped inductive load test circuit                                               | Unclamped inductive waveform                                                         |
|-------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------|
|  |  |

## 7 Package Outlines



**Figure 1 Outline PG-TO 252, dimensions in mm/inches**

## 8 Appendix A

### Table 11 Related Links

- **IFX C6 Product Brief:** [www.infineon.com](http://www.infineon.com)
- **IFX C6 Portfolio:** [www.infineon.com](http://www.infineon.com)
- **IFX CoolMOS Webpage:** [www.infineon.com](http://www.infineon.com)
- **IFX Design Tools:** [www.infineon.com](http://www.infineon.com)

## Revision History

IPD65R950C6

**Revision: 2013-07-26, Rev. 2.0**

Previous Revision

| Revision | Date       | Subjects (major changes since last revision) |
|----------|------------|----------------------------------------------|
| 2.0      | 2013-07-26 | Release of final version                     |

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